
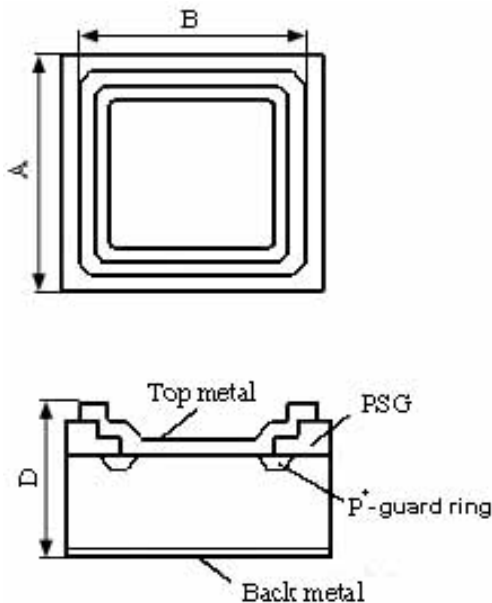


# SCHOTTKY DIODES KDN-01040B.



Rev.1. Feb. 2010

 <b>VSP-MIKRON</b>		<b>1A/40V.</b> Die Size-39mil.		
Electrical Characteristics	Symbol	Unit	Spec. limit	Die Sort
Breakdown Voltage @ $I_R=10mA$	$V_{BR}$	V	40	45
Average Rectified Forward Current	$I_{F(AV)}$	A	1,0	-
DC Forward Voltage @ 25°C, $I_F=1,0A$ @ 25°C, $I_F=2,0A$	$V_F$	V	0,48 0,58	0,46 0,56
Maximum Reverse Current @ 25°C, $V_R=45V$ @ 25°C, $V_R=40V$ 125°C, $V_R=40V$	$I_R$	mA	- 0,060 15,0	0,060 0,040 13,0
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	$I_{FSM}$	A	40	-
Peak Repetitive Reverse Surge Current @ 2,0µs, $f=1kHz.$ , $T_J<150°C.$	$I_{RRM}$	A	1,5	
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	ESD	kV	±8 (contact)	
Voltage Rate of Change	dV/dt	V/µS	10.000	
Operating Junction Temperature	$T_J$	°C	150	



DIM	ITEM	µm
$A_x$ $A_y$	Wafer Form Die Size	1000 1000
$B_x$ $B_y$	Top Metal Size	860 860
D	Thickness	300max.
Scribe line Width		80

Top metal: a) **Al-Ni-Ag** – for Soldering;  
 b) **Al** – for Wire Bond.  
 Backside metal: **Ti-Ni-Ag**.